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AMENDMENTS TO THE CLAIMS

Please amend claims 1, 2, 4-5, 7, 12-14, and 22 such that the status of the claims is as follows:

- 1. (Currently Amended) An integrated circuit wafer comprising:
 - an integrated circuit die having a device trimming fuse circuit;
 - a first pad positioned in a scribe lane adjacent the integrated circuit die; and
 - a first conductor extending from the <u>device trimming</u> fuse circuit to the first pad <u>to</u>

 <u>provide a current path by which</u>, <u>wherein</u> the integrated circuit <u>die</u> is

 <u>electrically</u> trimmed by selectively applying a signal from the first pad to the

 <u>device trimming</u> fuse circuit through the first conductor.
- 2. (Currently Amended) The integrated circuit wafer of claim 1 and further comprising:

 a second pad positioned in the scribe lane; and
 a second conductor extending from the device trimming fuse circuit to the second pad.
- 3. (Original) The integrated circuit wafer of claim 2 wherein the first and second pads are a fuse pad and a supply pad, respectively.
- 4. (Currently Amended) The integrated circuit of claim 1 wherein the <u>device trimming</u> fuse circuit includes a fuse and circuitry for sensing whether the fuse is blown.
- 5. (Currently Amended) The integrated circuit of claim [[3]] 4 wherein the fuse and the circuitry are aligned generally parallel to an edge of an integrated circuit die.
- 6. (Original) The integrated circuit of claim 5 wherein the conductor is oriented generally perpendicular to the edge.
- 7. (Currently Amended) An integrated circuit wafer comprising:

 a plurality of integrated circuit dice separated from one another by scribe lanes, the dice having device trimming fuse circuits adjacent the scribe lanes; and a plurality of pads positioned in the scribe lane and connected to the device trimming fuse circuits by conductors for selectively applying a fuse blowing signal to the device trimming fuse circuits to electrically trim electrical circuitry of the

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integrated circuit die, so that following singularization of the dice from the wafer, the pads are disconnected from the device trimming fuse circuits.

- 8. (Original) The integrated circuit wafer of claim 7 wherein the plurality of pads include a fuse pad and a power supply pad connected to each fuse circuit.
- 9. (Original) The integrated circuit wafer of claim 8 wherein each fuse circuit includes a fuse connected to the fuse pad and the power supply pad by the conductors which cross the die edges.
- 10. (Original) The integrated circuit wafer of claim 9 wherein each fuse circuit includes circuitry for sensing whether the fuse is blown.
- 11. (Original) The integrated circuit wafer of claim 7 wherein the fuse circuits are aligned in rows generally parallel to the scribe lanes.
- 12. (Currently Amended) A trimmable integrated circuit comprising:

 a plurality of <u>device trimming</u> fuses positioned adjacent a die edge of the integrated circuit;
 - a plurality of pads positioned in a scribe lane adjacent to the die edge; and a plurality of conductors extending across the die edge for connecting the pads and the <u>device trimming</u> fuses to allow <u>electrical</u> trimming of the integrated circuit by selective blowing of the <u>device trimming</u> fuses, the conductors being severable during singularization of the integrated circuit.
- 13. (Currently Amended) The trimmable integrated circuit of claim 13 wherein the <u>device</u> trimming fuses are aligned in a row generally parallel to the die edge.
- 14. (Currently Amended) The trimmable integrated circuit of claim 12 wherein a pair of adjacent device trimming fuses share one common pad.
- 15.-21. (Canceled)
- 22. (Currently Amended) An integrated circuit die having a plurality of device trimming fuse circuits adjacent a die edge and conductors extending from the <u>device trimming</u> fuse circuits to the

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die edge, the conductors providing connection between the <u>device trimming</u> fuse circuits and pads which are severed from the die subsequent to <u>electrical trimming</u> of the integrated circuit die by selectively blowing of fuses of the <u>device trimming</u> fuse circuits.

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